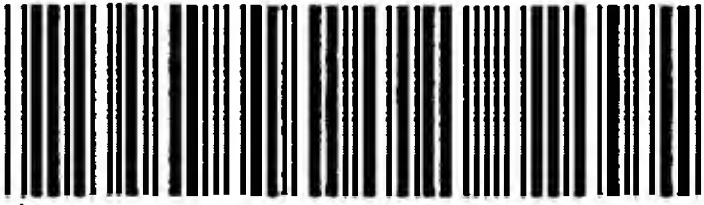


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/709,379	HWANG ET AL.	
	Examiner	Art Unit	
	Leith A. Al-Nazer	2821	

SEARCHED			
Class	Subclass	Date	Examiner
343	702	5/18/2005	LA
455	90.3	5/18/2005	LA
455	550.1	5/18/2005	LA
455	575.1	5/18/2005	LA
455	575.3	5/18/2005	LA
455	575.4	5/18/2005	LA
455	575.7	5/18/2005	LA

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST Text Search (see Examiner Search Notes)	5/18/2005	LA